

Docket No.: 60188-768

PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of	:	Customer Number: 20277
	:	
Kenji YONEDA	:	Confirmation Number:
	:	
Serial No.:	:	Group Art Unit:
	:	
Filed: February 10, 2004	:	Examiner: Unknown
	:	
For: METHOD FOR FABRICATING SEMICONDUCTOR DEVICE AND SEMICONDUCTOR DEVICE		

INFORMATION DISCLOSURE STATEMENT

Mail Stop IDS
Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

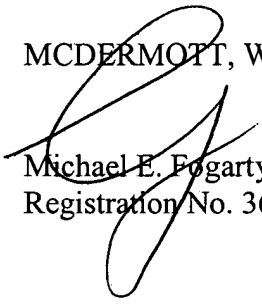
The relevance of the references listed on attached Form 1449 is discussed in the present specification.

Serial No.:

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

MCDERMOTT, WILL & EMERY



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INFORMATION DISCLOSURE CITATION IN AN APPLICATION (PTO-1449)				ATTY. DOCKET NO. 60188-768		SERIAL NO.		
				APPLICANT Kenji YONEDA				
				FILING DATE February 10, 2004		GROUP		
U.S. PATENT DOCUMENTS								
EXAMINER'S INITIALS	CITE NO.	Document Number		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear		
		Number-Kind Code ₂ (if known)						
		US						
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FOREIGN PATENT DOCUMENTS								
EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document		Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation	
		Country Codes -Number + -Kind Codes (if known)					Yes	No
		JP 29-37817		06/11/1999				
		JP 9-45679		02/14/1997	MATSUSHITA ELECTRON CORP		(Japan w/English Abstract)	
		JP 10-50701		02/20/1998	MATSUSHITA ELECTRON CORP KOBAYASHI HIKARI		(Japan w/English Abstract)	
		JP 10-79509		03/24/1998	TEXAS INSTR INC <TI>		(Japan w/English Abstract)	
		JP 10-223629		08/21/1998	MATSUSHITA ELECTRON CORP KOBAYASHI HIKARI		(Japan w/English Abstract)	
		JP 11-214386		08/06/1999	MATSUSHITA ELECTRON CORP KOBAYASHI HIKARI		(Japan w/English Abstract)	
		JP P2002-64093A		02/28/2002	JAPAN SCIENCE & TECHNOLOGY CORP		(Japan w/English Abstract)	
OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)								
EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.						
EXAMINER				DATE CONSIDERED				

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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.